

<b>Notice of References Cited</b>	Application/Control No. 10/606,675	Applicant(s)/Patent Under Reexamination ADAMCZYK ET AL.	
	Examiner /BINH K. TIEU/	Art Unit 2614	Page 1 of 1

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*	B	US-5,933,778	08-1999	Buhrmann et al.	455/461
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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